## Search Notes



Application/Control No.	Applicant(s)/Patent Under Reexamination
10709823	CHANG CHIEN ET AL.

Examiner Art Unit

TANH Q NGUYEN 2182

## SEARCHED

Class	Subclass	Date Examiner			
710	62-64,72-74,100,300,305,306,311,313,315 - limited search	05/04-05/07	TQN		
710	62-64,72-74,100,300,305,306 - limited search	11/05/07	TQN		

## **SEARCH NOTES**

Search Notes	Date	Examiner
inventor search - eDAN/East	05/04/07	TQN
East search - results attached	05/05,09/07	TQN
check for new matter	05/20/08	TQN

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Class	Subclass	Date	Examiner	

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